

2012 Annual Conference of the Prognostics and Health Management Society

An introduction to Prognosis, Uncertainty Representation, and Risk Measures

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1.1) PHM, Fault Diagnosis and Failure Prognosis







1.1) PHM, Fault Diagnosis and Failure Prognosis



1.1) PHM, Fault Diagnosis and Failure Prognosis







1.2) Process Monitoring: Virtual Sensors and PLS



Source: Adapted from Inman et al. (2005), p. 6





1.2) Process Monitoring: Virtual Sensors and PLS



Identification of a dynamic model for y(t) using controls and measured disturbances u(t), other plant outputs $\eta(t)$, and delayed plant outputs y(t-d)

Use of the dynamic model as soft-sensor in the absence of measurement y(t) due to unavailable sensor signal





1.2) Process Monitoring: Virtual Sensors and PLS

 $g_{cc}(t) = 0.498 \cdot g_{cc}(t-2) + 0.217 \cdot g_{cf}(t) - 0.046 \cdot L_{p}(t) - 0.217 \cdot \tau(t-2) - 0.115 \cdot g_{ff}(t) - 0.108 \cdot g_{ff}(t-7)$



1.2) Process Monitoring: PLS

 Some examples from a rougher flotation plant, where the copper grade is the controlled variable (g_{cc}[%]):



* CONTAC Ingenieros Ltda., Software "SCAN"





1.2) Process Monitoring: PLS

- Recursive algorithm that can find directions of "maximum explicability", building a relation between a group of input variables and a set of output variables.
- Method that eases Model Structure Determination and Parameter Estimation in linear-in-the-parameters models.

- In addition, it allows to statistically characterize the prediction error in multivariate models.
- Off-line estimation technique. Model parameters are assumed to be constant!





1.3) Parameter Uncertainty and Particle Filters

Concept of "Artificial Evolution"

$$\begin{cases} x(t+1) = f_t(x(t), x_\alpha(t), \omega_1(t)) \\ x_\alpha(t+1) = x_\alpha(t) + \omega_\alpha(t) \\ \text{Features}(t) = h_t(x(t), x_\alpha(t), v(t)) \end{cases}$$

- f_t and h_t are non-linear mappings.
- **x(t)** is the state vector.
- $\omega_1(t)$ and v(t) are non-Gaussian distributions
- $x_{\alpha}(t)$ is an state associated with an unknown model parameter α
- $\omega_{\alpha}(t)$ is zero-mean random noise





1.3) Parameter Uncertainty and Particle Filters



✤Particle: Duple{ $w_t^{(i)}, x_{0:t}^{(i)}$ }, being $x_{0:t}^{(i)}$ a realization of process state *pdf*.

- Every particle is associated with an scalar $W_t^{(i)}$, namely the weight
 - Sampled version of the PDF

We only need to study the propagation of particles in time!

✤ <u>Steps</u>:

- Predict the "a priori" PDF, using the model
- Update parameters, given the new measurement





2) Model Uncertainty and PF-based Fault Diagnosis







2) Model Uncertainty and PF-based Fault Diagnosis

Summary:

- Type I Error (False Positives) fixed at 5%
 - Design parameter
- <u>Type II Error</u> (*False Negatives*)

$$1 - \sum_{i} w_T^{(i)}$$
 such that $x_c^{(i)}(T) \ge z_{1-\alpha,\mu,\sigma^2}$

- Estimated Probability of Fault Condition = $E\{x_{d,2}\}$
- Fisher's Discriminant Ratio





2) Model Uncertainty and PF-based Fault Diagnosis



























• Dynamic Model for Feature Growth in Time:

 $\begin{cases} x_1(t+1) = x_1(t) + x_2(t) \cdot F(x_1(t), t, U) + \omega_1(t) \\ x_2(t+1) = x_2(t) + \omega_2(t) \end{cases}$

- $x_1(t)$ is a state representing the fault dimension under analysis
- $x_2(t)$ is a state associated with an unknown model parameter
- *U* are external inputs to the system (load profile, etc.)
- F(x(t), t, U) is a general time-varying nonlinear function
- $\omega_1(t)$ and $\omega_2(t)$ are white noises (non necessarily Gaussian)
- Predicted State Density:

$$\hat{p}(x_{t+k} \mid \hat{x}_{1:t+k-1}) \approx \sum_{i=1}^{N} w_{t+k-1}^{(i)} K\left(x_{t+k} - E\left[x_{t+k}^{(i)} \mid \hat{x}_{t+k-1}^{(i)}\right]\right)$$





PARTICLE FILTERING-BASED FRAMEWORK

- Estimating the Remaining Useful Life (RUL)
- Generation of Long-Term Predictions
- *p*-step predictions for a fault indicator
- Prediction entails large-grain uncertainty

$$\tilde{p}(x_{t+p} \mid y_{1:t}) = \int \tilde{p}(x_t \mid y_{1:t}) \prod_{j=t+1}^{t+p} p(x_j \mid x_{j-1}) dx_{t:t+p-1}$$
$$\approx \sum_{i=1}^{N} w_i^{(i)} \int \cdots \int p(x_{t+1} \mid x_t^{(i)}) \prod_{j=t+2}^{t+p} p(x_j \mid x_{j-1}) dx_{t+1:t+p-1}$$

















- ✓ First Approach for Long-Term Prediction: (Weight Update Procedure)
 - Predicted Trajectory: $\hat{x}_{t+p}^{(t)} = E[f_{t+p}(\tilde{x}_{t+p-1}^{(t)}, \omega_{t+p})] \quad ; \quad \hat{x}_{t}^{(t)} = \tilde{x}_{t}^{(t)}$
 - Predicted State pdf @ time t+k

$$\hat{p}(x_{t+k} \mid \hat{x}_{t+k-1}) \approx \sum_{i=1}^{N} \widehat{w_{t+k-1}^{(i)}} \hat{p}(x_{t+k}^{(i)} \mid \hat{x}_{t+k-1}^{(i)}) ; k = 1, \cdots, p$$
Predicted Conditional pdf (noise model)





✓ First Approach for Long-Term Prediction: (Weight Update Procedure)

Weight update for Long-Term Prediction

• Construct a partition of the random variable domain by defining:

$$d_{t+k}^{(1)} = -\infty; \quad d_{t+k}^{(N+1)} = \infty$$

$$d_{t+k}^{(j)} = \frac{1}{2} \left(\hat{x}_{t+k}^{(j)} + \hat{x}_{t+k}^{(j-1)} \right), \quad j = 2, \dots, N$$

• Generate the updated particle weights by computing:

$$w_{t+k}^{(i)} = \int_{d_{t+k}^{(i)}}^{d_{t+k}^{(i+1)}} \hat{p}(x_{t+k} \mid \hat{x}_{0:t+k-1}, y_{1:t}) dx_{t+k}$$





- ✓ Second Approach for Long-Term Prediction: (Regularization of Predicted State pdf)
- Uncertainty: Resampling procedure for predicted state pdf
- Statistical information given by the position of the particles, not by the particle weight.
- Use of Epanechnikov kernels

$$K_{opt}(x) = \begin{cases} \frac{n_x + 2}{2c_{n_x}} \left(1 - \|x\|^2\right) & \text{if } \|x\| < 1\\ 0 & \text{otherwise} \end{cases}$$

$$\hat{p}(x_{t+k} \mid \hat{x}_{1:t+k-1}) \approx \sum_{i=1}^{N} w_{t+k-1}^{(i)} K\left(x_{t+k} - E\left[x_{t+k}^{(i)} \mid \hat{x}_{t+k-1}^{(i)}\right]\right)$$

 $\int xK(x)dx$



 ✓ Second Approach for Long-Term Prediction: (Regularization of Predicted State pdf)

Long Term Predictions: Second Approach

- For $i = 1, \dots, N$, $w_{t+k}^{(i)} = N^{-1}$
- Calculate \hat{S}_{t+k} , the empirical covariance matrix of $\left\{ E\left[x_{t+k}^{(i)} \mid \hat{x}_{t+k-1}^{(i)}\right], w_{t+k}^{(i)}\right\}_{i=1}^{N}$

• Compute
$$\hat{D}_{t+k}$$
 such that $\hat{D}_{t+k}\hat{D}_{t+k}^T = \hat{S}_{t+k}$

• For $i = 1, \dots, N$, draw $\varepsilon^i \sim K$, the Epanechnikov kernel and assign

$$\hat{x}_{t+k}^{(i)*} = \hat{x}_{t+k}^{(i)} + h_{t+k}^{opt} \hat{D}_{t+k} \varepsilon^{i}$$

$$K_{opt}(x) = \begin{cases} \frac{n_x + 2}{2c_{n_z}} \left(1 - ||x||^2\right) & \text{if } ||x|| < 1\\ 0 & \text{otherwise} \end{cases}$$

$$h_{opt} = A \cdot N^{-\frac{1}{n_0 + 4}}$$
$$A = \left(8 c_{n_0}^{-1} \cdot (n_x + 4) \cdot \left(2\sqrt{\pi}\right)^{n_x}\right)^{\frac{1}{n_0 + 4}}$$







For *k* = 1, 2, 3, ...

- Use nonlinear State equation and Inverse Transform Resampling to obtain a set of equally weighted particles centered at $\left\{ E \left[x_{t+k}^{(i)} | \hat{x}_{t+k-1}^{(i)} \right] \right\}_{i=1}^{N}$
- Use Epanechnikov kernels and the Regularization algorithm to obtain a new set of equally weighted particles $\left\{\hat{x}_{t+k}^{(i)}\right\}_{i=1}^{N}$

• Calculate \hat{S}_{t+k} , the empirical covariance matrix of $\left\{ E \left[x_{t+k}^{(i)} \mid \hat{x}_{t+k-1}^{(i)} \right], w_{t+k}^{(i)} \right\}_{i=1}^{N}$

- Compute \hat{D}_{t+k} such that $\hat{D}_{t+k}\hat{D}_{t+k}^T = \hat{S}_{t+k}$
- For $i = 1, \dots, N$, draw $\varepsilon^i \sim K$, an Epanechnikov kernel and assign $\hat{x}_{t+k}^{(i)*} = \hat{x}_{t+k}^{(i)} + h_{t+k}^{opt} \hat{D}_{t+k} \varepsilon^i$





 ✓ <u>Third Approach for Long-Term Prediction</u>: (Projection in Time of State Expectations)

$$\hat{x}_{t+p}^{(i)} = E[f_{t+p}(\tilde{x}_{t+p-1}^{(i)}, \omega_{t+p})] \quad ; \quad \hat{x}_{t}^{(i)} = \tilde{x}_{t}^{(i)}$$

 $w_{t+k}^{(i)} = w_{t+k-1}^{(i)}$; $k = 1, \cdots, p$

- Simpler in terms of computational effort.
- Particle weights invariant for future time instants.
- When it works, sources of error are negligible compared to:
 - model inaccuracies
 - wrong assumptions about noise parameters

















4) Parameter Uncertainty and Outer Correction Loops







4) Parameter Uncertainty and Outer Correction Loops



4) Parameter Uncertainty and Outer Correction Loops

• Concept of "Artificial Evolution" revised

$$\begin{cases} x(t+1) = f_t(x(t), x_\alpha(t), \omega_1(t)) \\ x_\alpha(t+1) = x_\alpha(t) + \omega_\alpha(t) \\ \text{Features}(t) = h_t(x(t), x_\alpha(t), v(t)) \end{cases}$$

- f_t and h_t are non-linear mappings.
- **x(t)** is the state vector.
- $\omega_1(t)$ and v(t) are non-Gaussian distributions
- $x_{\alpha}(t)$ is an state associated with an unknown model parameter α
- $\omega_{\alpha}(t)$ is zero-mean random noise




Proposed Outer Correction Loop:

$$\begin{cases} \operatorname{var}\{\omega_{\alpha}(t+1)\} = p \cdot \operatorname{var}\{\omega_{\alpha}(t)\}, \text{ if } \frac{\|\operatorname{Pred}\operatorname{error}(t)\|}{\|\operatorname{Feature}(t)\|} < Th \\ \operatorname{var}\{\omega_{\alpha}(t+1)\} = q \cdot \operatorname{var}\{\omega_{\alpha}(t)\}, \text{ if } \frac{\|\operatorname{Pred}\operatorname{error}(t)\|}{\|\operatorname{Feature}(t)\|} > Th \end{cases}$$

• 0 , <math>q > 1, and 0 < Th < 1 are scalars





- Formally speaking...
- Assume a nonlinear state equation: $\begin{cases} x_{k+1} = x_k + \alpha_k \cdot F(x_k, \alpha_k) + \omega_k \\ \alpha_{k+1} = L(\alpha_k, e_k^s) + \omega_k' \end{cases}$ where $L(\alpha_k, e_k^s) = \alpha_k$ $y_k = x_k + v_k$

• First Approach:
$$var(\boldsymbol{\omega}'_{k}) \coloneqq \begin{cases} p \cdot var(\boldsymbol{\omega}'_{k}) & |e_{k}^{s}| \leq e^{th} \\ q \cdot var(\boldsymbol{\omega}'_{k}) & |e_{k}^{s}| > e^{th} \end{cases}$$

Second Approach:

$$L(\boldsymbol{\alpha}_{k}, \boldsymbol{e}_{k}^{s}) \coloneqq \begin{cases} \boldsymbol{\alpha}_{k} & \left| \boldsymbol{e}_{k}^{s} \right| \leq e^{th} \\ \boldsymbol{\alpha}_{k} + \eta \boldsymbol{e}_{k}^{s} & \left| \boldsymbol{e}_{k}^{s} \right| > e^{th} \end{cases}, \quad var(\boldsymbol{\omega}_{k+1}') \coloneqq \begin{cases} p \cdot var(\boldsymbol{\omega}_{k}') & \left| \boldsymbol{e}_{k}^{s} \right| \leq e^{th} \\ \boldsymbol{\sigma}_{0}^{2} & \left| \boldsymbol{e}_{k}^{s} \right| > e^{th} \end{cases}$$





• Classic PF-based Prognosis Framework:







• Outer Correction Loops in a PF-based Prognosis Framework:







- Results for Outer Correction Loops in a case study (several runs of the algorithm, given the stochastic nature of the filtering algorithm)
- ✓ Outer Correction Loop that modifies only the variance of model hyperparameters:

```
Mean of ToF Expectation = 540 cycles (ground truth = 650 cycles)
Mean of 95% CI Lower Limit = 503 cycles
Mean of 95% CI Upper Limit = 573 cycles
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✓ Outer Correction Loop that modifies only the expectation and variance of hyper-parameters:

Mean of ToF Expectation = 645 cycles (ground truth = 650 cycles) Mean of 95% CI Lower Limit = 608 cycles Mean of 95% CI Upper Limit = 681 cycles





<u>RUL On-line Precision Index (RUL-OPI)</u>:

- Considers the relative length of the 95% confidence interval computed at time t (CI_t), when compared to the remaining useful life.
- Quantifies the concept: "the more data the algorithm processes, the more precise the prognostic result"
- Good prognostic results are associated to values of $I_1(t) \approx 1$

$$I_{1}(t) = e^{-\left(\frac{\sup(CI_{t}) - \inf(CI_{t})}{E_{t}\{RUL\}}\right)} = e^{-\left(\frac{\sup(CI_{t}) - \inf(CI_{t})}{E_{t}\{ToF\} - t}\right)}$$
$$0 < I_{1}(t) \le 1, \forall t \in [1, E_{t}\{ToF\}), t \in \mathbb{N}$$





RUL Accuracy-Precision Index:

- Considers the error in the ToF estimate with respect to the length of the 95% confidence interval computed at time t (Ci_t) and penalizes the fact that $E_t \{ToF\} > Ground Truth \{ToF\}$
- Good prognostic results are associated to values of the index such that $0 \leq 1 I_2(t) \leq \mathcal{E}$

where \mathcal{E} is a small positive constant

$$I_{2}(t) = e^{-\left(\frac{Ground Truth\{ToF\} - E_{t}\{ToF\}}{\sup(CI_{t}) - \inf(CI_{t})}\right)}$$

$$0 < I_{2}(t), \forall t \in [1, E_{t}\{ToF\}), t \in \mathbb{N}$$





RUL On-line Steadiness Index (RUL-OSI):

- Considers the current estimate for the expectation of the time of failure (ToF) computed at time *t*.
- Quantifies the concept: "the more data the algorithm processes, the more steady the prognostic result"
- Good prognostic results are associated to small values for the RUL-OSI

$$I_{3}(t) = \sqrt{Var(E_{t} \{ToF\})}$$
$$I_{3}(t) \ge 0, \forall t \in \mathbb{N}$$





Application examples... ullet









- In order to accurately predict the Remaining Useful Life (RUL) of a failing system, one must consider the future, and often unpredictable, stresses that will be acting on the system.
 - How do these stresses affect the Remaining Useful Life (RUL)?
 - How does uncertainty in these stresses affect the RUL estimate?
 - How can uncertainty be quantified?
- Only after addressing these issues, it is possible to answer one particularly interesting question:
 - How can knowledge of uncertainty be used to extend the RUL of a failing system?











- A number of elements can alter in a significant manner the RUL of equipment and components.
- Consider, for example, uncertainty associated to load profiles, model errors, and measurement noise.
- Thus, RUL uncertainty (ΔRUL) can be written as:

• Level 1:
$$\Delta RUL = \left\{ \left[\frac{\partial RUL}{\partial model} \Delta model \right]^2 + \left[\frac{\partial RUL}{\partial load} \Delta load \right]^2 + \left[\frac{\partial RUL}{\partial meas} \Delta meas. \right]^2 \right\}^{1/2}$$

• Level 2: $\Delta load = \left\{ \left[\frac{\partial load}{\partial mission} \Delta mission \right]^2 + \left[\frac{\partial load}{\partial regime data} \Delta regime data \right]^2 + \left[\frac{\partial load}{\partial sensors} \Delta sensors \right]^2 \right\}^{1/2}$

• Level 3: This reasoning can be extrapolated analogously...





- Particle Filter (PF) algorithms have become a key component of failure prognosis frameworks:
 - Strong mathematical foundation
 - Allow online uncertainty representation of state estimates and long-term predictions in nonlinear systems
 - Allow online uncertainty management via the implementation of outer feedback correction loops.
- These facts motivate the usage of PF-based uncertainty measures to quantify, in real time, the impact of load, environmental, and other stresses for long-term prediction.





• If the input of the system is also assumed to be a stochastic process:



Dispersion Sensitivity



Confidence Interval Sensitivity

Dispersion Sensitivity Approach

(1)
$$stdev\{RUL_{Base+\sigma}\} = \frac{RUL_{D} - E\{RUL_{Base}\}}{Z_{0.95}}$$

(2) $stdev\{U_{Base+\sigma}\} = \left(\frac{stdev\{RUL_{Base+\sigma}\}}{stdev\{RUL_{Base}\}} - 1\right)\frac{stdev\{\omega\}}{DS - 1}$
(3) $U_d = U_{Base} - stdev\{U_{Base+\sigma}\}$
 $\sigma_o^{=}stdev\{RUL\}$
 $(stdev\{input\}=0\%)$
 15% $stdev\{\omega\}$
 \mathcal{C}^{DS-1}
 \mathcal{C}^{SD}

Confidence Interval Sensitivity Approach

(1)
$$Length(CI\{RUL_{Base+\sigma}\}) = 2(RUL_{D} - E\{RUL_{Base}\})$$

(2) $stdev\{U_{Base+\sigma}\} = \left(\frac{Length(CI\{RUL_{Base+\sigma}\})}{length(CI\{RUL_{Base}\})} - 1\right)\frac{stdev\{\omega\}}{CIS - 1}$
(3) $U_d = U_{Base} - stdev\{U_{Base+\sigma}\}$
(4) $U_d = U_{Base} - stdev\{U_{Base+\sigma}\}$
(5) $U_d = U_{Base+\sigma}$
(5) $U_d = U_{Base+\sigma}$
(5) $U_d = U_{Base+\sigma}$
(6) $U_d = U_{Base+\sigma}$
(6) $U_d = U_{Bas$

Case Study:

A critical component (planetary gear carrier plate) in a rotorcraft transmission system is experiencing a fatigue crack.

The baseline load on the rotorcraft is 120% of the maximum recommended torque. At this load, a failure is predicted to occur at time 594 cycles.

Dispersion Sensitivity

Dispersion Sensitivity Approach

 $U_{Base} = 120\% \implies \text{ToF: 594} \qquad DS_{15\%} = \frac{stdev\{RUL_{Base+\omega}\}}{stdev\{RUL_{Base}\}}$ $U_{D} = ? \implies \text{ToF: 714} \qquad = \frac{41.52cycles}{12.44cycles} = 3.3362$

Dispersion Sensitivity

Phmsociety 56

Dispersion Sensitivity Approach

 $U_{Base} = 120\% \implies \text{ToF: 594} \qquad DS_{15\%} = \frac{stdev\{RUL_{Base+\omega}\}}{stdev\{RUL_{Base}\}}$ $U_D = ? \implies \text{ToF: 714} \qquad = \frac{41.52cycles}{12.44cycles} = 3.3362$

(1)
$$stdev\{RUL_{Base+\varpi}\} = \frac{RUL_D - E\{RUL_{Base}\}}{Z_{0.95}} = \frac{714 - 594}{1.627} = 73.755$$

(2) $stdev\{U_{Base+\varpi}\} = \left(\frac{stdev\{RUL_{Base+\varpi}\}}{stdev\{RUL_{Base}\}} - 1\right)\frac{stdev\{\omega\}}{DS - 1} = 31.64\%$

Dispersion Sensitivity Approach lacksquare

Dispersion Sensitivity

Physical Stress of the second seco

 $DS_{15\%} = \frac{stdev\{RUL_{Base+\omega}\}}{stdev\{RUL_{Pase}\}}$ $U_{Base} = 120\% \implies \text{ToF: 594}$ $U_D = 88.36\% \implies$ ToF: 714 $=\frac{41.52cycles}{12.44cycles}=3.3362$

Actual Results from Fault Testing: $U_D = 93\%$

(1)
$$stdev\{RUL_{Base+\varpi}\} = \frac{RUL_D - E\{RUL_{Base}\}}{Z_{0.95}} = \frac{714 - 594}{1.627} = 73.755$$

(2) $stdev\{U_{Base+\varpi}\} = \left(\frac{stdev\{RUL_{Base+\varpi}\}}{stdev\{RUL_{Base}\}} - 1\right)\frac{stdev\{\omega\}}{DS - 1} = 31.64\%$

Confidence Interval Sensitivity Approach

 $U_{Base} = 120\% \implies \text{ToF: 594}$ $U_D = ? \implies \text{ToF: 714}$ Confidence Interval Sensitivity $CIS_{15\%} = \frac{Length(CI\{RUL_{Base}\})}{Length(\{RUL_{Base}\})}$ $= \frac{142cycles}{38cycles} = 3.7368$

Confidence Interval Sensitivity Approach

 $U_{Base} = 120\% \implies \text{ToF: 594}$ $U_D = ? \implies \text{ToF: 714}$ $CIS_{15\%} = \frac{Length(CI\{RUL_{Base+\omega}\})}{Length(\{RUL_{Base}\})}$ $= \frac{142cycles}{38cycles} = 3.7368$

(1) $Length(CI\{RUL_{Base+\varpi}\}) = 2(RUL_D - E\{RUL_{Base}\}) = 2(714 - 594) = 240$

(2)
$$stdev\{U_{Base+\varpi}\} = \left(\frac{Length(CI\{RUL_{Base+\varpi}\})}{Length(CI\{RUL_{Base}\})} - 1\right)\frac{stdev\{\omega\}}{CIS - 1} = 29.13\%$$

(3)
$$U_d = U_{Base} - stdev\{U_{Base+\sigma}\} = 120\% - 29.13\% = 90.87\%$$

Confidence Interval Sensitivity Approach

 $U_{Base} = 120\% \implies \text{ToF: 594}$ $U_D = 90.87\% \implies \text{ToF: 714}$ $U_D = 90.87\% \implies \text{ToF: 714}$ $CIS_{15\%} = \frac{Length(CI\{RUL_{Base}\})}{Length(\{RUL_{Base}\})}$ $= \frac{142cycles}{38cycles} = 3.7368$

(1) $Length(CI\{RUL_{Base+\varpi}\}) = 2(RUL_D - E\{RUL_{Base}\}) = 2(714 - 594) = 240$

(2)
$$stdev\{U_{Base+\varpi}\} = \left(\frac{Length(CI\{RUL_{Base+\varpi}\})}{Length(CI\{RUL_{Base}\})} - 1\right)\frac{stdev\{\omega\}}{CIS - 1} = 29.13\%$$

(3)
$$U_d = U_{Base} - stdev\{U_{Base+\varpi}\} = 120\% - 29.13\% = 90.87\%$$

Just-in-Time Point vs. RUL Expectations

Definition:

(R1)
$$\mathcal{R}(C) = C$$
 for all constants C ,
(R2) $\mathcal{R}((1-\lambda)X + \lambda X') \leq (1-\lambda)\mathcal{R}(X) + \lambda \mathcal{R}(X')$ for
 $\lambda \in (0,1)$ ("convexity")
(R3) $\mathcal{R}(X) \leq \mathcal{R}(X')$ when $X \leq X'$ ("monotonicity")
(R4) $\mathcal{R}(X) \leq 0$ when $||X^k - X||_2 \to 0$ with $\mathcal{R}(X^k) \leq 0$
("closedness")

It will also be called a coherent measure of risk in the basic sense if it also satisfies

 (R5) R(λX) = λR(X) for λ > 0 ("positive homogene-ity")

• Fault Value at Risk (FVaR) and Risk Assessment:

$$FVaR(t, t_{prognosis}) \Leftrightarrow \alpha = 0.95 = \int_{-\infty}^{FVaR(t, t_{prognosis})} \hat{p}(x_{t}^{1} | y_{t_{prognosis}}) dx_{t}^{1}$$

$$Risk_{FVaR}(t, t_{prognosis}) = \left(E\{Hazard Zone\} - FVaR(t, t_{prognosis})\right)^{-1}$$

$$I = \left(\frac{1}{2}\right)^{-0} + \left(\frac{1}{2}\right)^{-0} + \frac{1}{2}\right)^{-0} + \frac{1}{2}\left(\frac{1}{2}\right)^{-0} + \frac{1}{2}\left(\frac{1}{2}\right$$

- Data registering two different operational profiles (charge and discharge) at room temperature (NASA Ames Research Center).
- Charging is carried out in a constant current (CC) mode at 1.5[A] until the battery voltage reached 4.2[V] and then continued in a constant voltage mode until the charge current dropped to 20[mA].
- Discharge is carried out at a constant current (CC) level of 2[A] until the battery voltage fell to 2.5[V].
- The experiments were stopped when the batteries reached end-oflife (EOL) criteria, which was a 40% fade in rated capacity (from 2 [A-hr] to 1.2[A-hr]).

- **Normal** condition reflects the fact that the battery SOH is slowly diminishing as a function of the number of charge/discharge cycles
- **Anomalous** condition indicates an abrupt increment in the battery SOH (regeneration phenomena).
- To detect the condition of interest, a PF-based anomaly detection module is implemented using nonlinear model

Anomaly Detection Module: Self-recharge Phenomena

State Equation Dynamic Model

$$\begin{cases} \begin{bmatrix} x_{d,1}(t+1) \\ x_{d,2}(t+1) \end{bmatrix} = f_b \left(\begin{bmatrix} x_{d,1}(t) \\ x_{d,2}(t) \end{bmatrix} + n(t) \right) \\ x_{c1}(t+1) = (1-\beta)x_{c1}(t) + \omega_1(t) \\ x_{c2}(t+1) = 0.95x_{c2}(t) \cdot x_{d,2}(t) + 0.2x_{d,1}(t) + \omega_2(t) \end{cases}$$
$$y(t) = x_{c1}(t) + x_{c2}(t) \cdot x_{d,2}(t) + v(t)$$

$$f_b(x) = \begin{cases} \begin{bmatrix} 1 & 0 \end{bmatrix}^T, \text{ if } \|x - \begin{bmatrix} 1 & 0 \end{bmatrix}^T \| \le \|x - \begin{bmatrix} 0 & 1 \end{bmatrix}^T \| \\ \begin{bmatrix} 0 & 1 \end{bmatrix}^T, \text{ else} \\ \begin{bmatrix} x_{d,1}(0) & x_{d,2}(0) & x_{c1}(0) & x_{c2}(0) \end{bmatrix}^T = \begin{bmatrix} 1 & 0 & 2 & 0 \end{bmatrix}^T$$

SOH Estimation Module (Self-recharge Phenomena)

State Equation Dynamic Model

$$\begin{cases} x_1(t+1) = x_1(t) + C \cdot x_2(t) \cdot (a - b \cdot t + t^2)^m + \omega_1(t) \\ x_2(t+1) = x_2(t) + \omega_2(t) \\ x_3(t+1) = \alpha \cdot x_3(t) + \omega_3(t) \end{cases}$$

 $y(t) = x_1(t) + x_3(t) + v(t)$

- $x_1(t)$ is a state representing the fault dimension
- $x_2(t)$ is a state associated with an unknown model parameter
- $x_3(t)$ is a state associated with the capacity regeneration phenomena
- *a*, *b*, *C* and *m* are constants associated to the duration and intensity of the battery load cycle (external input *U*)

SOH Estimation Module (Self-recharge Phenomena)

State Equation Dynamic Model

 $\begin{cases} x_1(k+1) = \eta_c x_1(k) + x_2(k) x_1(k) + w_1(k) \\ x_2(k+1) = x_2(k) + w_2(k) \\ x_3(k+1) = \delta(U(k)) \cdot [w_{31}(k)] + \delta(1 - U(k)) \cdot [x_3(k)w_{31}(k)] + \delta(2 - U(k)) \cdot [x_3(k) + w_{31}(k)] \end{cases}$

 $y(k) = x_1(k) + [\delta(1 - U(k)) + \delta(2 - U(k))]x_3(k) + v(k)$

- η_c is the Coulombic efficiency
- x_1 is a state representing the battery SOH
- x_2 is a state associated with an unknown model parameter
- x_3 is a state associated with the added SOH due to regeneration phenomena
- U is a external input associated with the apparition of regeneration phenomena
- w_1, w_2, w_{31}, w_{32} , and v are iid non-Gaussian noises























- <u>State-of-Charge Prognosis</u>:
 - Probabilistic characterization of usage conditions
 - Real-time state estimation/prognosis
 - Self-tuning model (parameter estimation)
 - PF-based framework allows to compute confidence bounds for SOC predictions
 - Modeling the future usage







 <u>State-of-Charge Prognosis</u>: (Preliminary Results)









• <u>State-of-Charge Prognosis</u>: (Preliminary Results)



8.3) Case Study: PF-based Risk Analysis in Finance



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 $\sigma_{1}^{2} = \omega + \alpha \sigma_{t-1}^{2} \eta_{t-1}^{2} + \beta \sigma_{t-1}^{2}$



8.3) Case Study: PF-based Risk Analysis in Finance

$$\begin{array}{lcl} \sigma_t^2 &=& \omega + \alpha \sigma_{t-1}^2 \eta_{t-1}^2 + \beta \sigma_{t-1}^2 \\ r_t &=& \mu + \sigma_t \epsilon_t \end{array}$$

1.4 🗖 1.4 Volatility Estimation, iteration 1 r_t: Return process Data Classical PF Risk sensitive PF • σ_t : Stochastic volatility 1.2 • $\mu \in \mathbb{R}$ • $\omega \in \mathbb{R}^+$ 0.8 Volatility • α, β : Parameters in $[0, 1]^2$ 0.6 • $\epsilon_t \sim \mathcal{N}(0, 1)$ 0.4 • $\eta_t \sim \mathcal{N}(0, \sigma)$ 0.2 OL 150 50 100 200 250 300 350 400 Time [days] Phmsociety ⁸¹



Questions?







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